

STGIF10CH60TS-L

Datasheet - production data

SLLIMM[™] - 2nd series IPM, 3-phase inverter, 15 A, 600 V short-circuit rugged IGBT

Arking area SDIP2F-26L (type L) 26

Features

- IPM 15 A, 600 V 3-phase IGBT inverter bridge including 2 control ICs for gate driving and freewheeling diodes
- 3.3 V, 5 V TTL/CMOS inputs with hysteresis
- Internal bootstrap diode
- Under-voltage lockout of gate drivers
- Smart shutdown function
- Short-circuit protection
- Shutdown input/fault output
- Separate open emitter outputs
- Built-in temperature sensor
- Comparator for fault protection
- Short-circuit rugged TFS IGBTs
- Very fast, soft recovery diodes
- 85 kΩ NTC UL 1434 CA 4 recognized
- Fully isolated package
- Isolation rating of 1500 Vrms/min

Applications

- 3-phase inverters for motor drives
- Home appliances such as washing machines, refrigerators, air conditioners and sewing machine

Description

This second series of SLLIMM (small low-loss intelligent molded module) provides a compact, high performance AC motor drive in a simple, rugged design. It combines new ST proprietary control ICs (one LS and one HS driver) with the improved short-circuit rugged trench gate fieldstop (TFS) IGBT, making it ideal for 3-phase inverter systems such as home appliances and air conditioners. SLLIMM[™] is a trademark of STMicroelectronics.

Table	1.	Device	summary
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Order code	Marking	Package	Packaging
STGIF10CH60TS-L	GIF10CH60TS-L	SDIP2F-26L	Tube

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October 2015
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DocID026331 Rev 5

This is information on a product in full production.

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1 Internal schematic and pin description

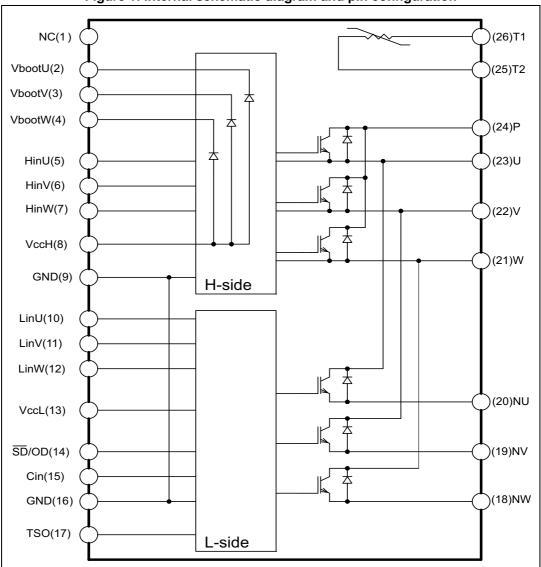


Figure 1. Internal schematic diagram and pin configuration



Pin	Symbol	Description
1	NC	-
2	VBOOTu	Bootstrap voltage for U phase
3	VBOOTv	Bootstrap voltage for V phase
4	VBOOTw	Bootstrap voltage for W phase
5	HINu	High-side logic input for U phase
6	HIN∨	High-side logic input for V phase
7	HINw	High-side logic input for W phase
8	VCCH	High-side low voltage power supply
9	GND	Ground
10	LINu	Low-side logic input for U phase
11	LINv	Low-side logic input for V phase
12	LINw	Low-side logic input for W phase
13	VCCL	Low-side low voltage power supply
14	SD/OD	Shutdown logic input (active low) / open-drain (comparator output)
15	CIN	Comparator input
16	GND	Ground
17	TSO	Temperature sensor output
18	NW	Negative DC input for W phase
19	NV	Negative DC input for V phase
20	NU	Negative DC input for U phase
21	W	W phase output
22	V	V phase output
23	U	U phase output
24	Р	Positive DC input
25	T2	NTC thermistor terminal 2
26	T1	NTC thermistor terminal 1

Table 2. Pin description



2 Absolute maximum ratings

(T_j= 25°C unless otherwise noted).

Table 3. Inverter parts						
Symbol	Parameter	Value	Unit			
V _{PN}	Supply voltage between P -N _U , -N _V , -N _W	450	V			
V _{PN(surge)}	Supply voltage surge between P -N _U , -N _V , -N _W	500	V			
V _{CES}	Collector-emitter voltage each IGBT	600	V			
.1	Continuous collector current each IGBT (T _C = 25 °C)	15	А			
±I _C	Continuous collector current each IGBT (T _C = 80 °C)	10	A			
±I _{CP}	Peak collector current each IGBT (less than 1ms)	30	А			
P _{TOT}	Total dissipation at T_{C} =25°C each IGBT	33	W			
t _{scw}	Short circuit withstand time, V_{CE} = 300V, T_J = 125 °C, V_{CC} = V_{boot} = 15 V, V_{IN} = 0 to 5 V	5	μs			

Table 3. Inverter parts

Table 4. Control parts

Symbol	Parameter	Min	Max	Unit
V _{CC}	Supply voltage between V_{CCH} -GND, V_{CCL} -GND	-0.3	20	V
V _{BOOT}	Bootstrap voltage	-0.3	619	V
V _{OUT}	Output voltage between U, V, W and GND	V _{BOOT} - 21	V _{BOOT} + 0.3	V
V _{CIN}	Comparator input voltage	-0.3	20	V
V _{IN}	Logic input voltage applied between HINx, LINx and GND	-0.3	15	V
V _{SD} /OD	Open drain voltage	-0.3	7	V
I _{SD} /OD	Open drain sink current	-	10	mA
V _{TSO}	Temperature sensor output voltage	-0.3	5.5	V
I _{TSO}	Temperature sensor output current		7	V

Table 5. Total system

Symbol	Parameter	Value	Unit
V _{ISO}	Isolation withstand voltage applied between each pin and heat sink plate (AC voltage, $t = 60$ sec.)	1500	Vrms
ТJ	Power chips operating junction temperature	-40 to 175	°C
Т _С	Module case operation temperature	-40 to 125	°C



Symbol	Parameter	Value	Unit
P	Thermal resistance junction-case single IGBT	4.6	00/M
Tth(j-c)		5.5	°C/W

Table 6. Thermal data



Electrical characteristics 3

 $(T_i = 25^{\circ}C \text{ unless otherwise noted}).$

Symbol	Parameter	Test condition	Min	Тур	Max	Unit
I _{CES}	Collector-cut off current	V _{CE} = 600 V, V _{CC} = V _{boot} = 15 V	-		100	μA
	Collector-emitter	$V_{CC} = V_{Boot} = 15 \text{ V}, \text{ V}_{IN}^{(1)} = 0 \text{ to } 5 \text{ V},$ $I_{C} = 10 \text{ A},$	-	1.5	1.95	
V _{CE(sat)}	saturation voltage	$V_{CC} = V_{Boot} = 15 \text{ V}, V_{IN}^{(1)} = 0 \text{ to } 5 \text{ V},$ $I_{C} = 15 \text{ A},$	-	1.65		
.,		V _{IN} ⁽¹⁾ = 0, I _C = 10 A	-	1.6	2.25	V
V _F	Diode forward voltage	V _{IN} ⁽¹⁾ = 0, I _C = 15 A	-	1.7		V
Inductiv	e load switching time a	and energy ⁽²⁾		1		1
t _{on}	Turn-on time		-	287		
t _{c(on)}	Cross-over time on	$V_{DD} = 300 \text{ V}, V_{CC} = V_{boot} = 15 \text{ V},$ $V_{IN}^{(1)} = 0 \text{ to } 5 \text{ V}, I_C = 10 \text{ A}$	-	146		1
t _{off}	Turn-off time		-	370		nc
t _{c(off)}	Cross-over time off		-	105		ns
t _{rr}	Reverse recovery time		-	270		
Eon	Turn-on switching loss		-	281		
E _{off}	Turn-off switching loss		-	121		μJ
E _{rr}	Reverse recovery energy loss			23		
t _{on}	Turn-on time		-	315		
t _{c(on)}	Cross-over time on		-	175		
t _{off}	Turn-off time		-	346		
t _{c(off)}	Cross-over time off		-	89		ns
t _{rr}	Reverse recovery time	$V_{DD} = 300 \text{ V}, V_{CC} = V_{boot} = 15 \text{ V},$	-	280		
Eon	Turn-on switching loss	V _{IN} ⁽¹⁾ = 0 to 5 V, I _C = 15 A	-	459		
E _{off}	Turn-off switching loss		-	175		μJ
E _{rr}	Reverse recovery energy loss			34		

Table 7. Inverter parts

1. Applied between HINx, LINx and GND for x = U, V, W

 t_{on} and t_{off} include the propagation delay time of the internal drive. $t_{\text{C(on)}}$ and $t_{\text{C(off)}}$ are the switching time of IGBT itself under the internally given gate driving condition. 2.



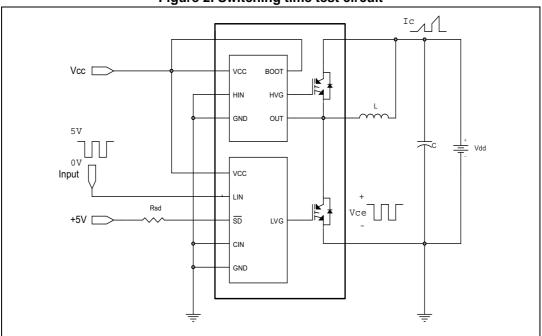
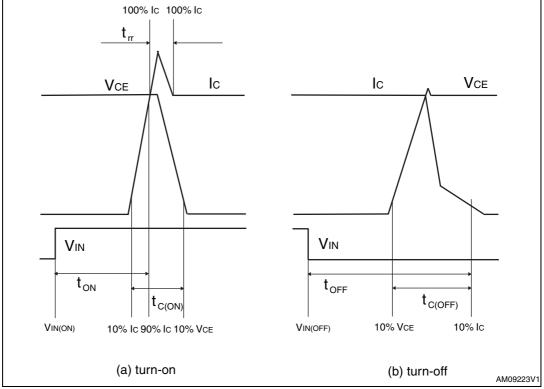


Figure 2. Switching time test circuit





Symbol	Parameter	Test condition	Min	Тур	Max	Unit
V _{il}	Low logic level voltage			176	0.8	V
					0.0	
V _{ih}	High logic level voltage		2			V
I _{INh}	IN logic "1" input bias current	IN _x =15V	80	150	200	μA
I _{INI}	IN logic "0" input bias current	IN _x =0V			1	μA
High side						
V _{CC_hys}	V _{CC} UV hysteresis		1.2	1.4	1.7	V
V _{CCH_th(on)}	V _{CCH} UV turn-on threshold		11	11.5	12	V
V _{CCH_th(off)}	V _{CCH} UV turn-off threshold		9.6	10.1	10.6	V
V _{BS_hys}	V _{BS} UV hysteresis		0.5	1	1.6	V
V _{BS_th(on)}	V _{BS} UV turn-on threshold		10.1	11	11.9	V
V _{BS_th(off)}	V _{BS} UV turn-off threshold		9.1	10	10.9	V
I _{QBSU}	Under voltage V _{BS} quiescent current	V _{BS} = 9 V, HINx ⁽¹⁾ = 5V;		55	75	μA
I _{QBS}	V _{BS} quiescent current	V _{CC} = 15 V, HINx ⁽¹⁾ = 5V		125	170	μA
I _{qccu}	Under voltage quiescent supply current	V _{CC} = 9 V, HINx ⁽¹⁾ = 0		190	250	μA
I _{qcc}	Quiescent current	$V_{CC} = 15 \text{ V}, \text{HINx}^{(1)} = 0$		560	730	μA
R _{DS(on)}	BS driver ON resistance			150		Ω
Low side				L	L	
V _{CC_hys}	V _{CC} UV hysteresis		1.1	1.4	1.6	V
V _{CCL_th(on)}	V _{CCL} UV turn-on threshold		10.4	11.6	12.4	V
V _{CCL_th(off)}	V _{CCL} UV turn-off threshold		9.0	10.3	11	V
I _{qccu}	Under voltage quiescent supply current	$V_{CC} = 10 \text{ V}, \overline{\text{SD}} \text{ pulled to}$ 5V through $R_{SD} = 10k\Omega$, CIN = LINx ¹⁾ = 0;		600	800	μA
I _{qcc}	Quiescent current	$V_{CC} = 15 \text{ V}, \overline{\text{SD}} = 5\text{V},$ CIN = LINx ¹⁾ = 0;		700	900	μA
V _{SSD}	Smart SD unlatch threshold		0.5	0.6	0.75	V
I _{SDh}	SD logic "1" input bias current	<u>SD</u> = 5∨	25	50	70	μA
I _{SDI}	SD logic "0" input bias current	SD =0V			1	μA

Table 8. Control / protection parts



			-			
Symbol	Parameter	Test condition	Min	Тур	Max	Unit
Temperature sensor output						
V _{TSO}	Temperature sensor output voltage	T _j = 25 °C		1.4		V
I _{TSO_SNK}	Temperature sensor sink current capability			0.1		mA
I _{TSO_SRC}	Temperature sensor source current capability		4			mA

Table 8. Control / protection parts (continued)

1. Applied between HINx, LINx and GND for x = U, V, W

Symbol	Parameter	Test condition	Min	Тур	Max	Unit
I _{CIN}	CIN input bias current	V _{CIN} =1V	-0.2		0.2	μA
V _{ref}	Internal reference voltage		460	510	560	mV
V _{OD}	Open drain low level output voltage	I _{od} = 5mA			500	mV
t _{CIN_SD}	C _{IN} comparator delay to SD	$\overline{\text{SD}}$ pulled to 5V through R _{SD} =10k Ω ; measured applying a voltage step 0-1V to Pin CIN 50% CIN to 90% $\overline{\text{SD}}$	150	230	320	ns
SR _{SD}	SD fall slew rate	\overline{SD} pulled to 5V through $R_{SD}=10k\Omega$; $C_L=1nF$ through \overline{SD} and ground; 90% \overline{SD} to 10% \overline{SD}		25		V/µs

Table 9. Sense comparator (V_{CC} = 15 V, unless otherwise is specified)

Note: Comparator stay enabled even if V_{CC} is in UVLO condition but higher than 4 V.



4 Fault management

The device integrates an open-drain output connected to \overline{SD} Pin. As soon as a fault occurs the open-drain is activated and LVGx outputs are forced low. Two types of fault can be pointed out:

- Overcurrent (OC) sensed by the internal comparator (see more detail in Section 4.2: Smart shutdown function);
- Undervoltage on supply voltage (V_{CC});

Each fault enables the SD open drain for a different time; refer to the following *Table 10: Fault timing*.

Symbol	Parameter	Event time SD open-drain en time result		
ос	Over-current event ≤ 20 μs		20 µs	
OC Over-current event		≥ 20µs	OC time	
		≤ 50 µs	50µs	
UVLO Under-voltage lock out event		≥ 50µs until the VCC_LS exceed the VCC_LS UV turn ON threshold	UVLO time	

Tahla	10	Fault	timing
Table	10.	гаин	uming

Actually the device remains in a fault condition (\overline{SD} at low logic level and LVGx outputs disabled) for a time also depending on RC network connected to \overline{SD} pin. The network generate a time contribute that add up to the internal value.

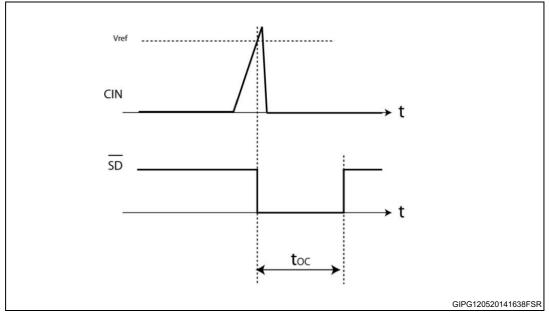


Figure 4. Overcurrent timing (without contribution of RC network on \overline{SD})



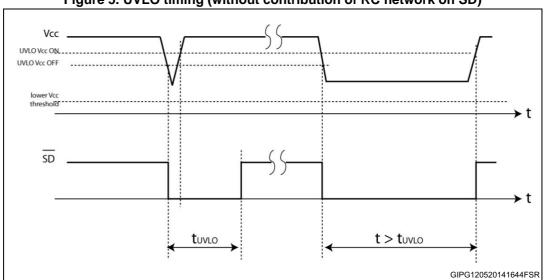


Figure 5. UVLO timing (without contribution of RC network on \overline{SD})

4.1 TSO output

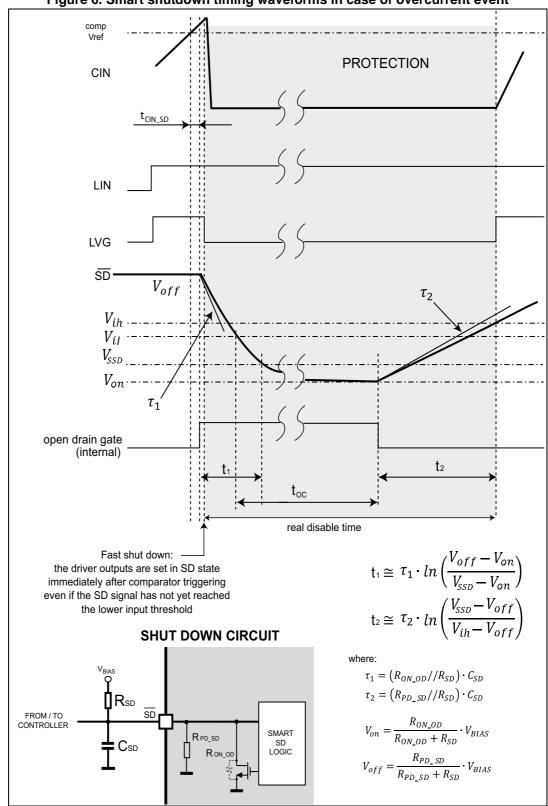
The device integrates temperature sensor. A voltage proportional to die temperature is available on TSO pin. When this function is not used the Pin can be left floating.

4.2 Smart shutdown function

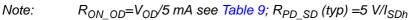
The device integrates a comparator committed to the fault sensing function. The comparator input can be connected to an external shunt resistor in order to implement a simple overcurrent detection function.

The output signal of the comparator is fed to an integrated MOSFET with the open drain output available on SD input. When the comparator triggers, the device is set in shutdown state and its outputs are all set to low level.











In common over-current protection architectures the comparator output is usually connected to the SD input and an RC network is connected to this SD line in order to provide a monostable circuit, which implements a protection time that follows the fault condition.

Differently from the common fault detection systems, the device Smart shutdown architecture allows to immediately turn-off the outputs gate driver in case of fault, by minimizing the propagation delay between the fault detection event and the actual outputs switch-off. In fact the time delay between the fault and the outputs turn off is no more dependent on the RC value of the external network connected to the pin.

In the smart shutdown circuitry, the fault signal has a preferential path which directly switches off the outputs after the comparator triggering.

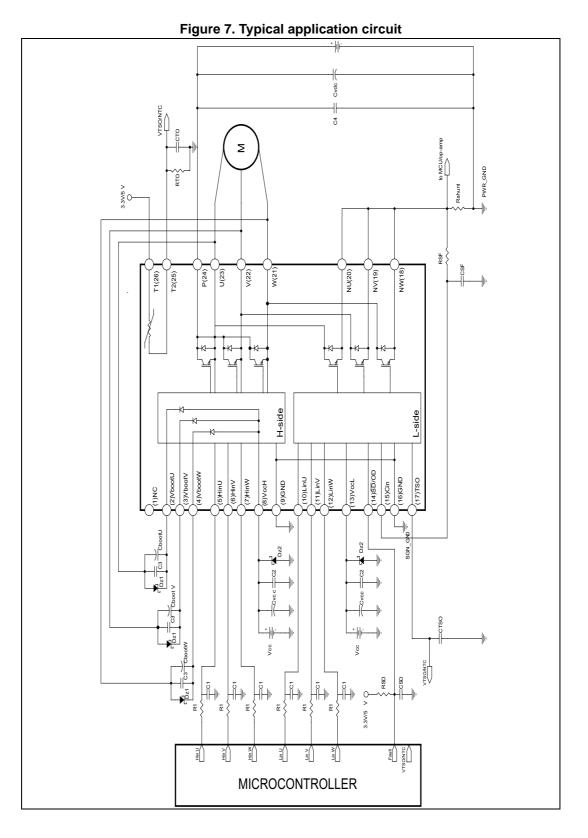
At the same time the internal logic turns on the open drain output and holds it on until the \overline{SD} voltage goes below the V_{SSD} threshold and t_{oc} time is elapsed.

The driver outputs restart following the input pins as soon as the voltage at the \overline{SD} pin reaches the higher threshold of the \overline{SD} logic input.

The Smart shutdown system provides the possibility to increase the time constant of the external RC network (that is the disable time after the fault event) up to very large values without increasing the delay time of the protection.



5 Typical application circuit





6 Recommendations

- 1. Input signals HIN, LIN are active-high logic. A 500 k Ω (typ.) pull-down resistor is built-in for each high side input. To prevent input signal oscillation, the wiring of each input should be as short as possible and the use of RC filters (R1, C1) on each input signal is suggested. The filters should be done with a time constant of about 100 ns and must be placed as close as possible to the IPM input pins.
- 2. The bypass capacitor Cvcc (aluminum or tantalum) is recommended to reduce the transient circuit demand on the power supply. In addition, a decoupling capacitor C_2 (100 to 220 nF, with low ESR and low ESL) is suggested, to reduce high frequency switching noise distributed on the power supply lines. It must be placed as close as possible to each Vcc pin and in parallel to the bypass capacitor.
- 3. The use of RC filter (RSF, CSF) for preventing protection circuit malfunction is recommended. The time constant (RSF x CSF) should be set to 1us and the filter must be placed as close as possible to the CIN pin.
- 4. The \overline{SD} is an input/output pin (open drain type if used as output). It should be pulled up to MCU power supply (3.3/5 V) by a resistor higher than 1.0 k Ω in order to keep I_{od} lower than 5 mA. The filter on SD has to be sized to get a desired re-starting time after a fault event and placed as close as possible to the SD pin.
- 5. To increase the noise immunity of the TSO thermal sensor, it is recommended to parallel a decoupling capacitor C_{TSO} between 1 nF and 10 nF. Similarly, if the NTC thermistor is available and used, it is recommended to parallel a decoupling capacitor C_{OT} between 10 nF and 100 nF. In both cases, the capacitors must be placed close to the MCU.
- 6. The decoupling capacitor C₃ (100 to 220 nF, with low ESR and low ESL) in parallel with each C_{boot} is recommended to filter high frequency disturbances. Both C_{boot} and C₃ must be placed as close as possible to the U,V,W and V_{boot} pins. Bootstrap negative electrodes should be connected to U,V,W terminals directly and separated from the main output wires.
- 7. A Zener diode (Dz1) between each V_{cc} pin and GND, and in parallel (Dz2) with each Cboot is suggested in order to prevent overvoltage.
- 8. The decoupling capacitor C_4 (100 to 220 nF, with low ESR and low ESL) in parallel with the electrolytic capacitor Cvdc is recommended, in order to prevent surge destruction. Both capacitors C_4 and Cvdc should be placed as close as possible to the IPM (C_4 has priority over Cvdc).
- 9. By integrating an application-specific type HVIC inside the module, direct coupling to the MCU terminals without an opto-coupler is possible.
- 10. Low inductance shunt resistors should be used for phase leg current sensing
- 11. In order to avoid malfunctions, the wiring between N pins, the shunt resistor and PWR_GND should be as short as possible.
- 12. It is recommended to connect SGN_GND to PWR_GND at only one point (near the terminal of shunt resistor), in order to avoid any malfunction due to power ground fluctuation.



Symbol	Parameter	Test condition	Min	Тур	Max	Unit
V _{PN}	Supply voltage	Applied between P-Nu, N_V , N_w		300	400	V
V _{CC}	Control supply voltage	Applied between V _{CC} -GND	13.5	15	18	V
V _{BS}	High side bias voltage	Applied between V _{BOOTi} -OUT _i for i = U, V, W	13		18	V
t _{dead}	Blanking time to prevent Arm-short	For each input signal	1.0			μs
f _{PWM}	PWM input signal	-40 °C < T _C < 100 °C -40 °C < T _j < 125 °C			20	kHz
т _с	Case operation temperature				100	°C

Table 11. Recommended operating conditions



NTC thermistor 7

Symbol	Parameter	Test condition	Min	Тур	Max	Unit
R ₂₅	Resistance	T = 25°C		85	-	kΩ
R ₁₂₅	Resistance	T = 125°C		2.6	-	kΩ
В	B-constant	T = 25°C to 100°C		4092	-	К
т	Operating temperature range		-40		125	°C

Table 12. NTC thermistor

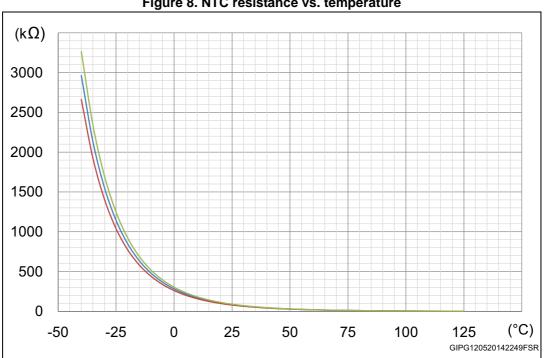


Figure 8. NTC resistance vs. temperature



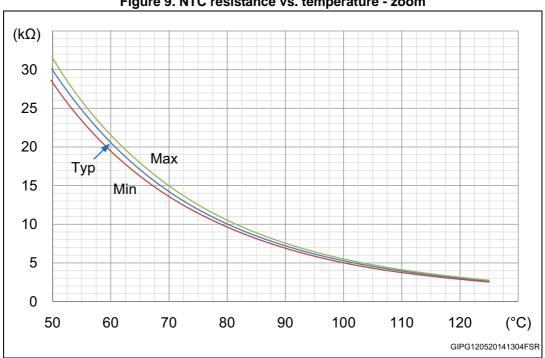
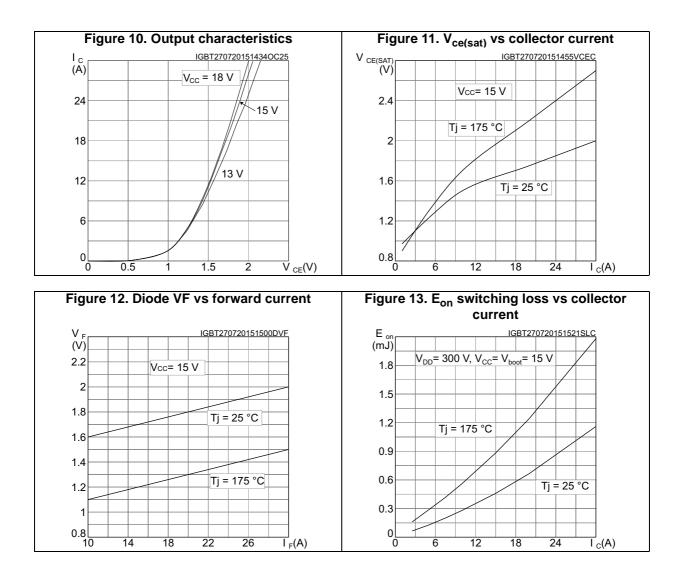


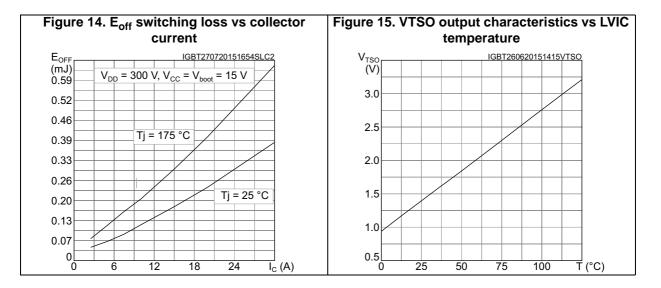
Figure 9. NTC resistance vs. temperature - zoom

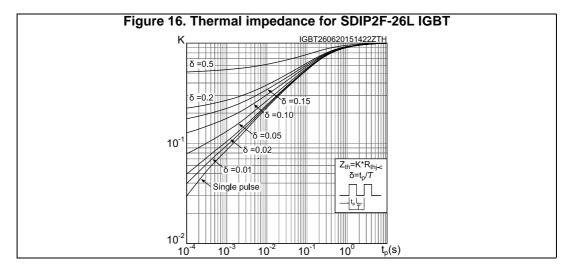


8 Electrical characteristics (curves)











9 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.



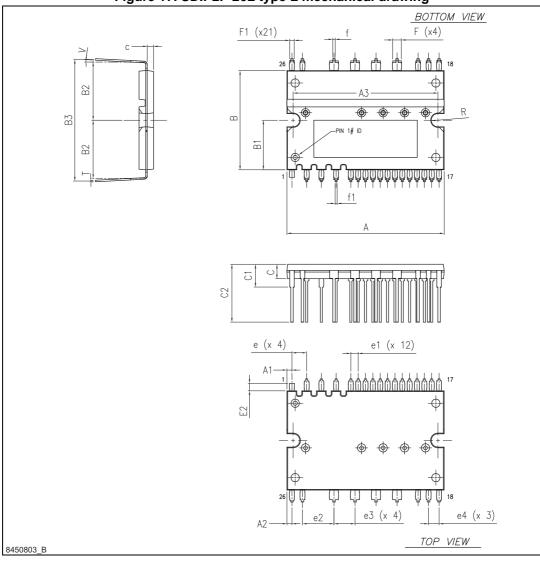


Figure 17. SDIP2F-26L type L mechanical drawing

Table 13. SDIP2F-26L type L mechanical dimensions⁽¹⁾

Ref.	Dimensions	Ref.	Dimensions	Ref.	Dimensions
А	38.00 ± 0.50	B3	29.40 ± 0.50	e4	2.54 ± 0.20
A1	1.22 ± 0.25	С	3.50 ± 0.20	f	0.60 ± 0.15
A2	1.22 ± 0.25	C1	5.50 ± 0.50	f1	0.50 ± 0.15
A3	35.00 ± 0.30	C2	14.00 ± 0.50	F	2.10 ± 0.15
С	1.50 ± 0.05	е	3.556 ± 0.200	F1	1.10 ± 0.15
В	24.00 ± 0.50	e1	1.778 ± 0.200	R	1.60 ± 0.20
B1	12.00	e2	7.62 ± 0.20	Т	0.400 ± 0.025
B2	14.40 ± 0.50	e3	5.08 ± 0.20	V	0° / 5°

1. All dimensions are expressed in millimeters.



10 Revision history

Table 14. Document revision history				
Date Revision		Changes		
15-May-2014	1	Initial release.		
27-Aug-2014	2	Updated Table 1: Device summary.		
27-Jul-2015	3	Updated Section 2: Absolute maximum ratings, Section 3: Electrical characteristics. Added Section 8: Electrical characteristics (curves).		
03-Sep-2015	4	Modified: Features Modified: Figure 1, 6 and 7 Minor text changes		
01-Oct-2015	5 Document status promoted from preliminary to production data.			

Table 14. Document revision history



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